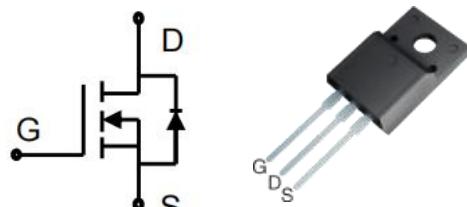


N-Channel Super Junction MOSFET 800V/7A

Parameter	Value	Unit
V _{DS}	800	V
R _{DS(on)}	0.68	Ω
I _D	7	A



TO-220F

FEATURES

- Ultra low R_{DS(on)}
- Ultra low gate charge (typ. Q_g=17.9nC)
- 100% UIS tested

APPLICATIONS

- Power factor correction (PFC)
- Switched mode power supplies (SMPS)
- Uninterruptible power supply (UPS)

MAXIMUM RATED VALUES(at TC=25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	800	V
Continuous drain current ¹⁾ (T _c =25°C) (T _c =100°C)	I _D	7 4.5	A A
Pulsed drain current ²⁾	I _{DM}	21	A
Gate-Source voltage	V _{GSS}	±30	V
Avalanche energy, single pulse ³⁾	E _{AS}	120	mJ
Power Dissipation	P _D	29	W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C
Continuous diode forward current	I _S	7	A
Diode pulse current	I _{S,pulse}	21	A

THERMAL CHARACTERISTICS

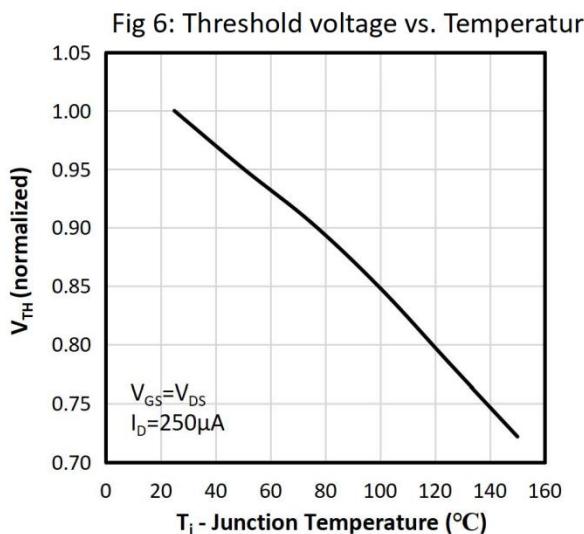
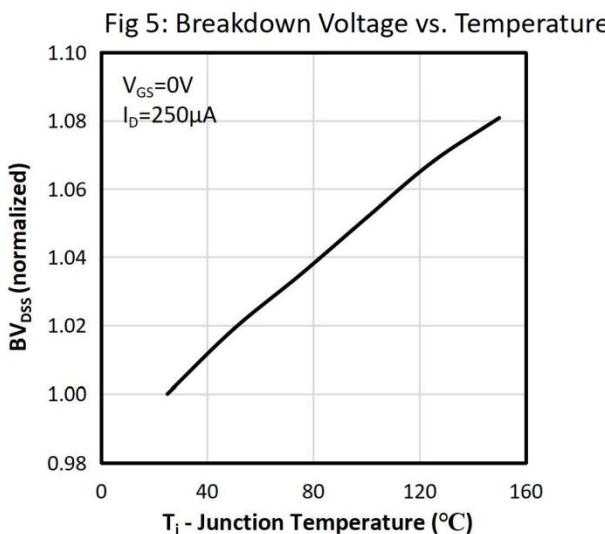
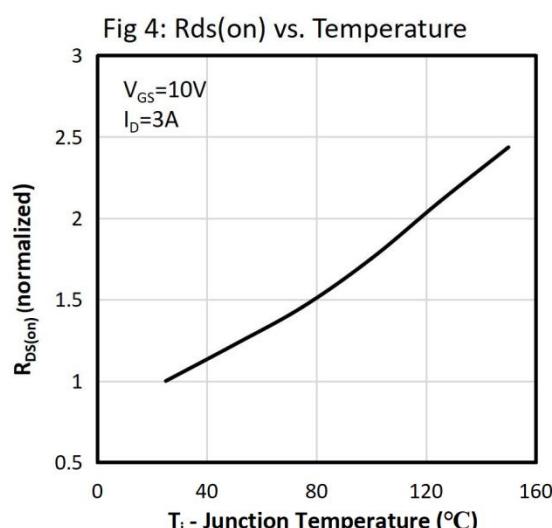
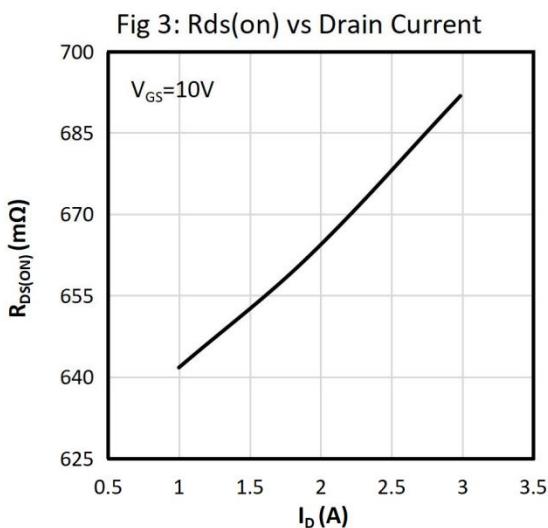
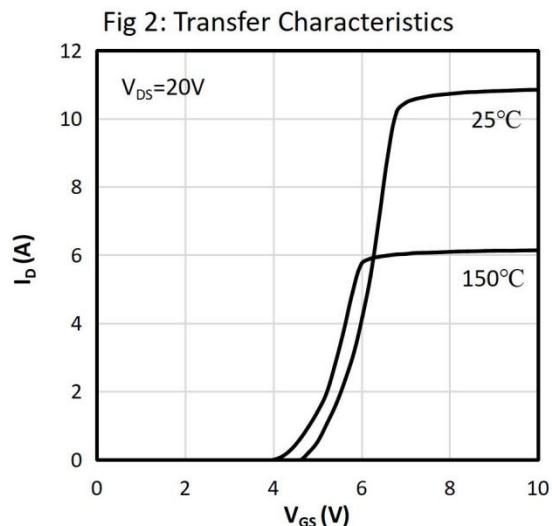
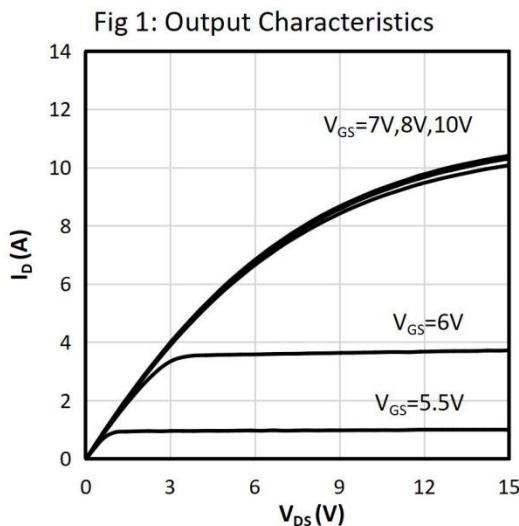
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	4.3	°C/W
Thermal Resistance, Junction-to-Ambient, minimal Footprint ⁴⁾	R _{θJA}	62	°C/W
Soldering temperature, wave soldering only allowed at leads. (1.6mm from case for 10s)	T _{sold}	260	°C

ELECTRICAL CHARACTERISTICS($T_c = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-source breakdown voltage	V_{BDSS}	$V_{GS}=0\text{V}$, $I_D=250\mu\text{A}$	800	-	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$	3.0	4.2	5.0	V
Drain cut-off current	I_{DSS}	$V_{DS}=800\text{V}$, $V_{GS}=0\text{ V}$, $T_j=25^\circ\text{C}$	-	-	1	μA
Gate leakage current, Forward	I_{GSSF}	$V_{GS}=30\text{V}$, $V_{DS}=0\text{ V}$	-	-	100	nA
Gate leakage current, Reverse	I_{GSSR}	$V_{GS}=-30\text{V}$, $V_{DS}=0\text{ V}$	-	-	-100	nA
Drain-source on-state resistance	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}$, $I_D=3\text{A}$ $T_j=25^\circ\text{C}$ $T_j=150^\circ\text{C}$	- - -	0.68 1.68	0.9	Ω
Gate resistance	R_G	$f=1\text{ MHz}$, open drain	-	6.09	-	Ω
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{DS}=100\text{V}$, $V_{GS}=0\text{V}$, $f=250\text{kHz}$	-	749.2	-	pF
Output capacitance	C_{oss}		-	24.1	-	
Reverse transfer capacitance	C_{rss}		-	0.7	-	
Turn-on delay time	$t_{d(\text{on})}$	$V_{DD}=400\text{V}$, $I_D=3\text{A}$ $R_G=10\Omega$, $V_{GS}=10\text{V}$	-	44.7	-	ns
Rise time	t_r		-	16.6	-	
Turn-off delay time	$t_{d(\text{off})}$		-	34.2	-	
Fall time	t_f		-	27.1	-	
Gate charge characteristics						
Gate to source charge	Q_{gs}	$V_{DD}=640\text{V}$, $I_D=3\text{A}$, $V_{GS}=0$ to 10 V	-	3.9	-	nC
Gate to drain charge	Q_{gd}		-	8.0	-	
Gate charge total	Q_g		-	17.9	-	
Gate plateau voltage	$V_{plateau}$		-	5.3	-	V
Reverse diode characteristics						
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}$, $I_F=3\text{A}$	-	-	1.1	V
Reverse recovery time	t_{rr}	$V_R=400\text{V}$, $I_F=3\text{A}$, $dI/dt=100\text{ A}/\mu\text{s}$	-	255.3	-	ns
Reverse recovery charge	Q_{rr}		-	1789.2	-	nC
Peak reverse recovery current	I_{rrm}		-	15.14	-	A

Notes:

1. Limited by maximum junction temperature and duty cycle. TO-220 equivalent.
2. Limited by maximum junction temperature, maximum duty cycle is 0.75.
3. $I_{AS}=2\text{A}$, $L=60\text{mH}$, $V_{DD}=60\text{V}$, Starting $T_j=25^\circ\text{C}$.
4. The value of R_{thJA} is measured by placing the device in a still air box which is one cubic foot.

CHARACTERISTICS DIAGRAMS


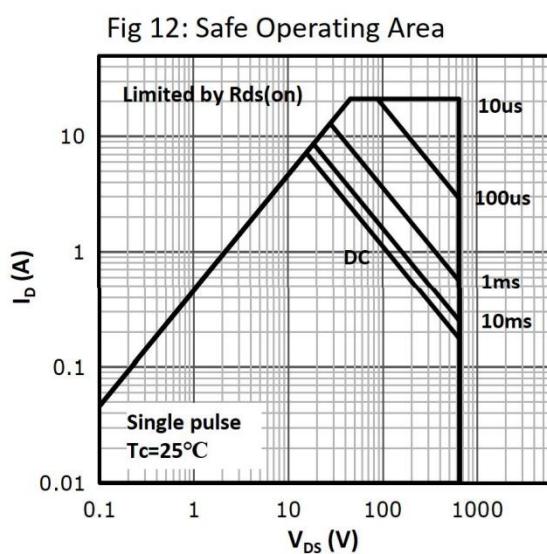
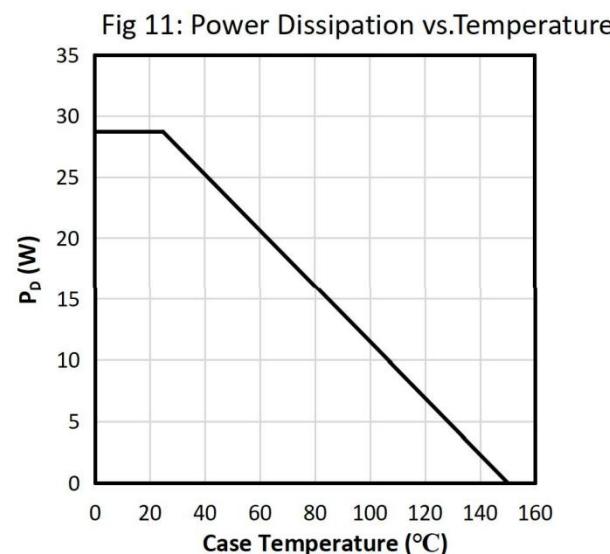
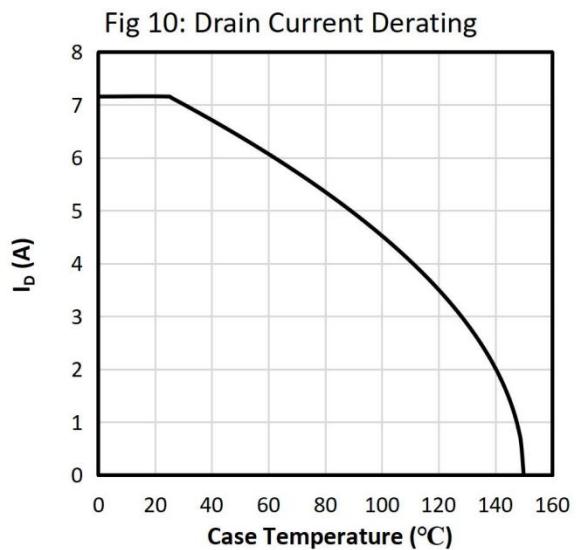
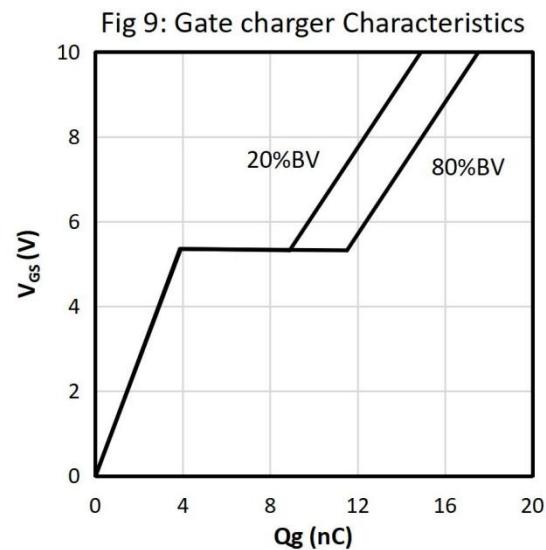
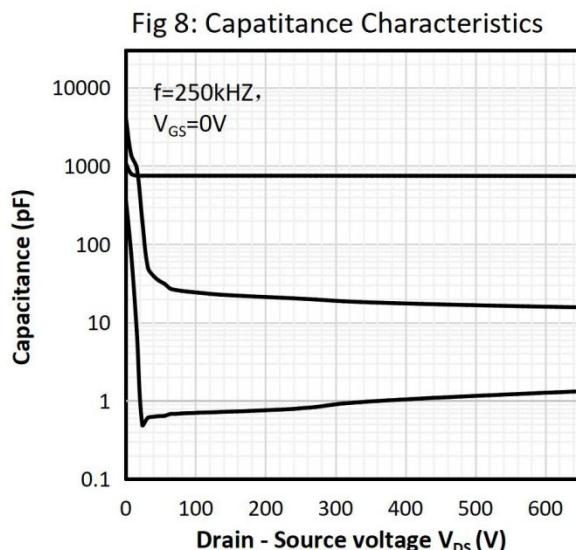
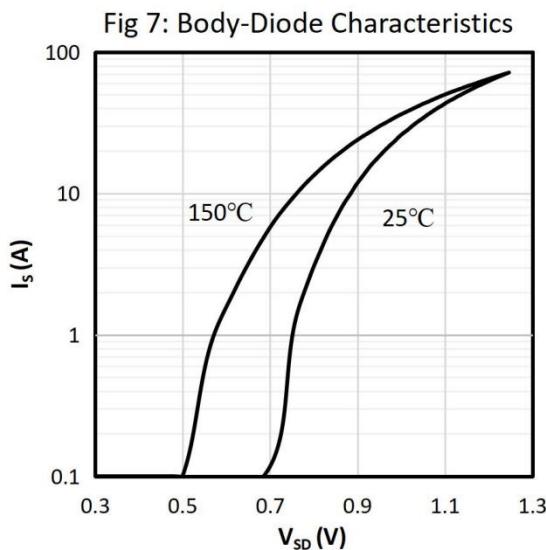
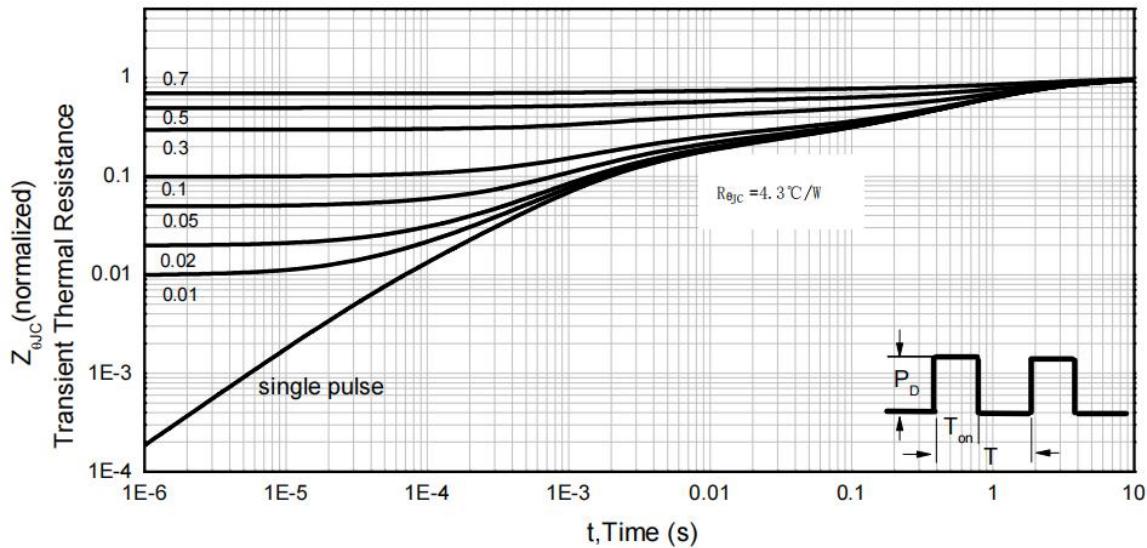
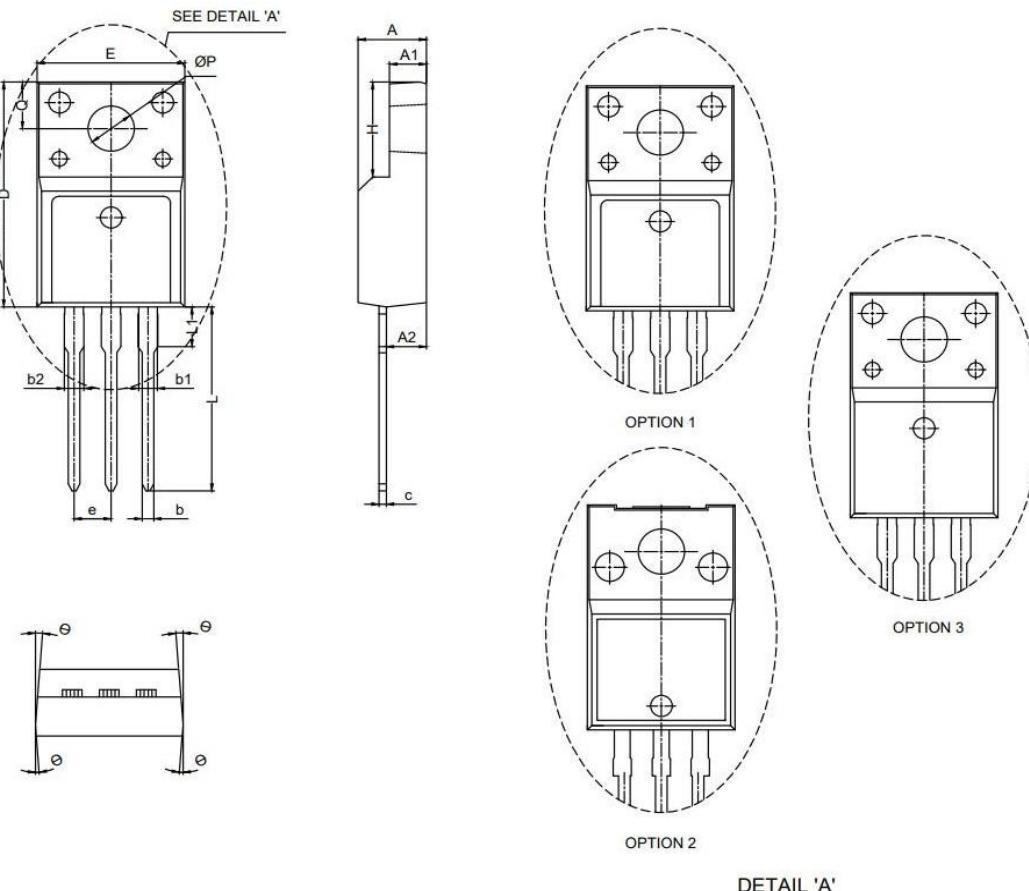


Fig 13: Normalized Maximum Transient Thermal Impedance (R_{thJC})



PACKAGE OUTLINE



SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.40	4.90	0.173	0.193
A1	2.34	2.74	0.092	0.108
A2	2.50	2.96	0.098	0.117
b	0.70	1.00	0.028	0.039
b1	1.18	1.43	0.046	0.056
b2	1.15	1.58	0.045	0.062
c	0.40	0.70	0.016	0.028
D	15.57	16.40	0.613	0.646
E	9.96	10.40	0.392	0.409
e	2.54 BSC		0.100 BSC	
H	6.48	7.25	0.255	0.285
L	12.64	14.20	0.498	0.559
L1	2.90	3.60	0.114	0.142
ØP	3.00	3.38	0.118	0.133
Q	3.10	3.50	0.122	0.138
Θ	1°	5°	1°	5°

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